

### **Features**

- High isolation 5000 VRMS
- CTR flexibility available see order information
- DC input with transistor output
- Temperature range 55 °C to 110 °C

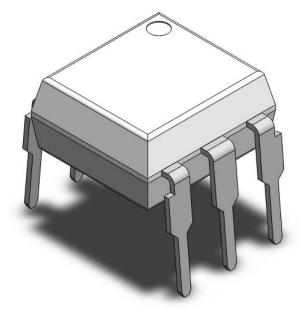
## **Applications**

- Switch mode power supplies
- Computer peripheral interface
- Microprocessor system interface

## **Description**

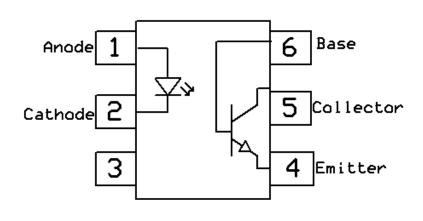
The 4N2X, 4N3X and H11AX series consists of a phototransistor optically coupled to a gallium arsenide Infrared-emitting diode in a 6-lead DIP package with bending options.

## **Package Outline**



Note: Different bending options available. See package dimension.

### **Schematic**





Absolute Maximum Rating at 25°C

Symbol	Parameters	Ratings	Units	Notes
Viso	Isolation voltage	5000	V <sub>RMS</sub>	
Topr	Operating temperature	-55 ~ +110	°C	
Тѕтс	Storage temperature	-55 ~ +125	°C	
TsoL	Soldering temperature	260	°C	
Emitter				
I <sub>F</sub>	Forward current	60	mA	
I <sub>F(TRANS)</sub>	Peak transient current (≤1µs P.W,300pps)	1	А	
$V_R$	Reverse voltage	6	V	
P <sub>D</sub>	Power dissipation	100	mW	
Detector				
P <sub>D</sub>	Power dissipation	150	mW	
Bvceo	Collector-Emitter Breakdown Voltage	80	V	
Вусво	Collector-Base Breakdown Voltage	80	V	
B <sub>VECO</sub>	Emitter-Collector Breakdown Voltage	7	V	
Вуево	Emitter-Base Breakdown Voltage	7	V	



## **Electrical Characteristics** $T_A = 25$ °C (unless otherwise specified)

#### **Emitter Characteristics**

Symbol	Parameters	Test Conditions	Min	Тур	Max	Units	Notes
VF	Forward voltage	I <sub>F</sub> =10mA		1.2	1.4	V	
I <sub>R</sub>	Reverse Current	V <sub>R</sub> = 6V	-	-	5	μΑ	
Cin	Input Capacitance	f= 1kHz	-	45	-	pF	

#### **Detector Characteristics**

Symbol	Parameters		Test Conditions	Min	Тур	Max	Units	Notes
B <sub>VCEO</sub>	Collector-Emitter E	Breakdown	Ic= 100μA	80	-	-	V	
Bveco	Emitter-Collector Breakdown		I <sub>E</sub> = 1mA	7	-	-	V	
Вусво	Collector-Base Breakdown		Ic= 100μA	80		-	V	
Вуево	Emitter-Base Breakdown		I <sub>E</sub> = 100μA	7	-	-	V	
lana	Collector-Emitter	4N2X, H11AX	V <sub>CE</sub> = 10V, I <sub>F</sub> =0mA	1		45	nA	
ICEO	Dark Current	4N3X	V <sub>CE</sub> =60V, I <sub>F</sub> =0mA	1		45	nA	
Ісво	Collector-Base Dark Current		V <sub>CB</sub> = 10V, I <sub>F</sub> =0mA	•	•	20	nA	

### **Transfer Characteristics**

Symbol	Parameters		Test Conditions	Min	Тур	Max	Units	Notes
	Current	4N35, 4N36, 4N37	I <sub>F</sub> = 10mA, V <sub>CE</sub> = 10V	100	-	-	%	
		4N25,4N26, 4N38,		20		-		
CTR		H11A2, H11A3			- 			
CIK	Transfer Ratio	4N27, 4N28, H11A4		10	-	-		
	Rallo	H11A1		50	-	-		
		H11A5		30	ı	ı		
	Collector-	4N2X	I <sub>F</sub> = 50mA, I <sub>C</sub> = 2mA	ı	ı	0.5		
V	Emitter	4N35,4N36,4N37	1 40m A 1 0 5m A	-	-	0.3	V	
V <sub>CE</sub> (SAT)	Saturation	H11AX	I <sub>F</sub> = 10mA, I <sub>C</sub> = 0.5mA	-	-	0.4	V	
	Voltage	4N38	I <sub>F</sub> = 20mA, I <sub>C</sub> = 4mA		-	1.0		
Rio	Isolation Resistance		Vio= 500VDC	1x10 <sup>11</sup>	-		Ω	
C <sub>IO</sub>	Isolation Capacitance		f= 1Mhz		0.25		pF	

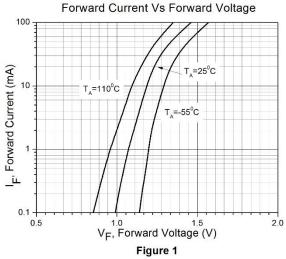


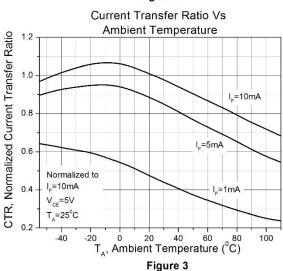
## **Switching Characteristics**

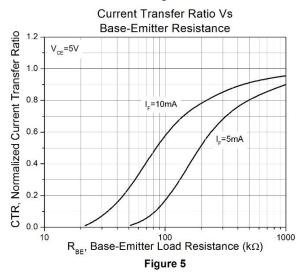
Symbol	Para	nmeters	Test Conditions	Min	Тур	Max	Units	Notes
_	T <sub>ON</sub> Turn On Time	4N2X, H11AX	I <sub>F</sub> = 10mA, V <sub>CE</sub> = 10V, R <sub>L</sub> = 100Ω	-	2.6	9.8	μs –	
ION		4N3X	$I_c$ = 2mA, $V_{CE}$ = 10V, $R_L$ = 100 $\Omega$	-	9.5	11.5		
Toss	Turn Off Time	4N2X, H11AX	I <sub>F</sub> = 10mA, V <sub>CE</sub> = 10V, R <sub>L</sub> = 100Ω	ı	2.6	9.8		
Toff	Turn Oir Time	4N3X	$I_c$ = 2mA, $V_{CE}$ = 10V, $R_L$ = 100 $\Omega$	-	9.5	11.5	μs	

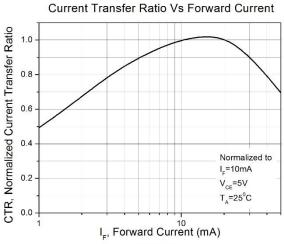


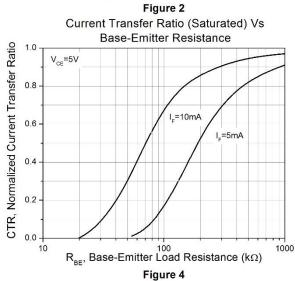
## **Typical Characteristic Curves**

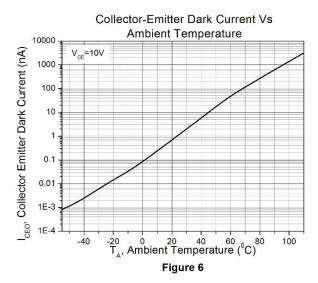




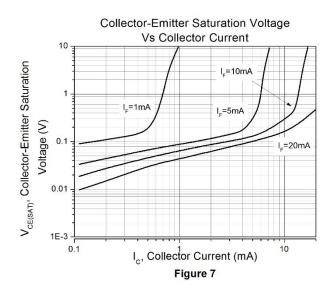


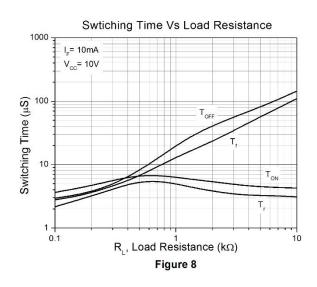


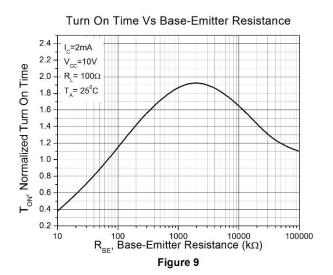


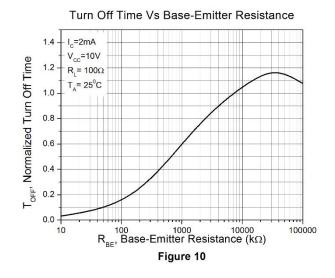








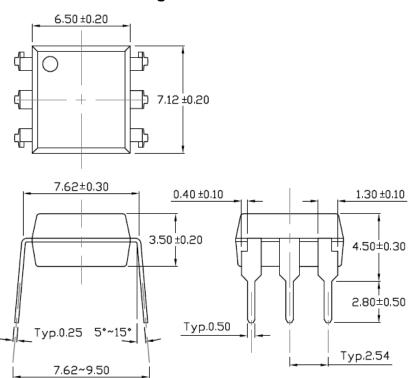




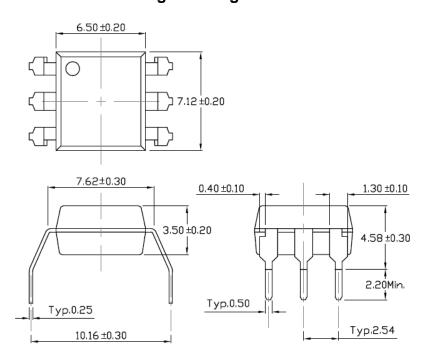


## Package Dimension Dimensions in mm unless otherwise stated

### Standard DIP - Through Hole

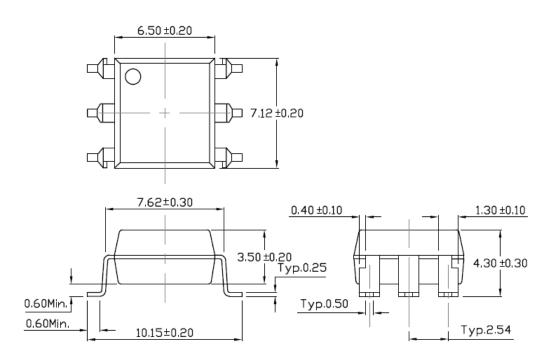


## Wide Lead Forming - Through Hole

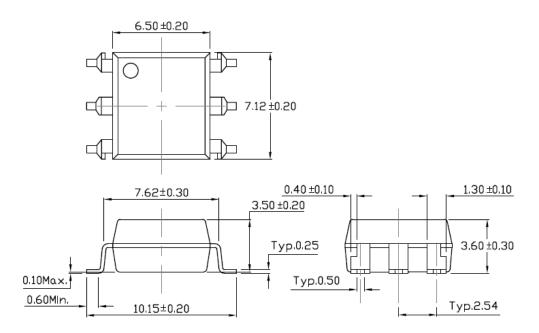




### **Surface Mount Forming**

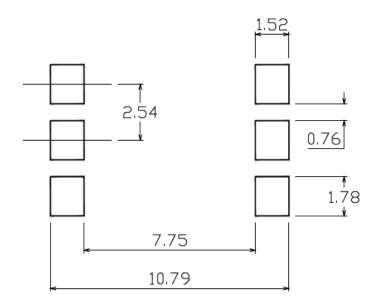


## **Surface Mount Forming (Low Profile)**

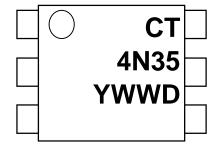




## Recommended Solder Mask Dimensions in mm unless otherwise stated



## **Marking Information**



### Note:

CT: Logo

4N35 : Product Number

Y : Fiscal Year WW : Work Week

D : Production Code



## **Ordering Information**

4N2X(Y)(Z)-G, 4N3XY(Z)-G, H11AXY(Z)-G

X = (5,6,7,8 for 4N2X & 4N3X series), (1,2,3,4,5 for H11AX series)

Y = Lead form option (S, SL, M or none)

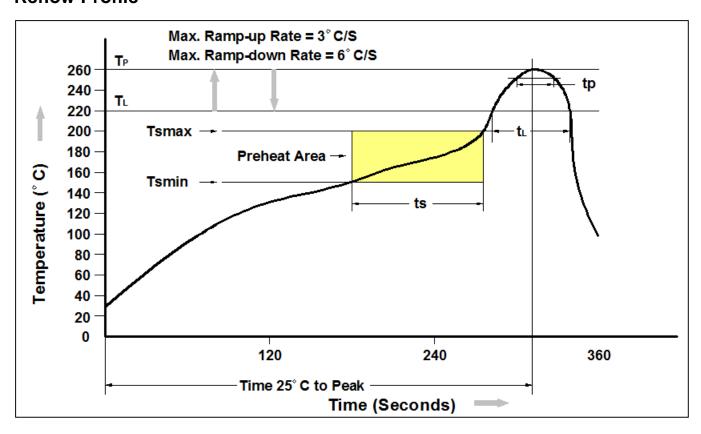
Z = Tape and reel option (TA, TB or none)

G= Material option (G: Green, None: Non-green)

Option	Description	Quantity
None	Standard 6 Pin Dip	50Units/Tube
М	Wide Lead Forming	50Units/Tube
S(TA)	Surface Mount Lead Forming – With Option A Taping	1000 Units/Reel
S(TB)	Surface Mount Lead Forming – With Option B Taping	1000 Units/Reel
SL(TA)	Surface Mount Lead Forming(Low Profile) – With Option A Taping	1000 Units/Reel
SL(TB)	Surface Mount Lead Forming(Low Profile) – With Option B Taping	1000 Units/Reel



### **Reflow Profile**



Profile Feature	Pb-Free Assembly Profile
Temperature Min. (Tsmin)	150°C
Temperature Max. (Tsmax)	200°C
Time (ts) from (Tsmin to Tsmax)	60-120 seconds
Ramp-up Rate (t∟ to t <sub>P</sub> )	3°C/second max.
Liquidous Temperature (T <sub>L</sub> )	217°C
Time (t <sub>L</sub> ) Maintained Above (T <sub>L</sub> )	60 – 150 seconds
Peak Body Package Temperature	260°C +0°C / -5°C
Time (t <sub>P</sub> ) within 5°C of 260°C	30 seconds
Ramp-down Rate (T <sub>P</sub> to T <sub>L</sub> )	6°C/second max
Time 25°C to Peak Temperature	8 minutes max.



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